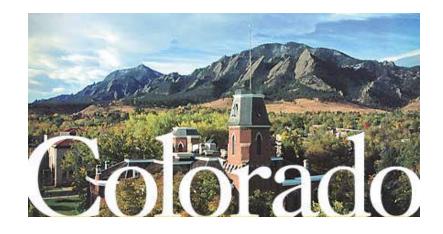
- Materials System Approach
- The Criteria
- Basic Research Issues



Polymer Derived Graded EBCs

Rishi.Raj@Colorado.edu (Boulder)

In Alliance with Honeywell ES&S (Phoenix AZ)

> ORNL-EBC (Nashville) Nov. 6-7, 2002

THE PROBLEM

Silicon Nitride Vanes

1066°C-1260°C; 8.9 atm, $p_{H_2O} = 0.101$ 162m/s to 573 m/sec

- 27% of cross section lost in 1818 h
- recession and mechanical degradation
- Si_3N_4 grains are oxidizing and then volatilizing

"Evaluation of Mechanical Reliability of Silicon Nitride Vanes after Field Tests in an Industrial Gas Turbine" Liu, Ferber, Westphal and Macri(ORNL report - I assume)

A Tenet

silica passivation mechanism for oxidation protection is not viable for the exposed surfaces of Si₃N₄ vanes and blades in humid combustion environment

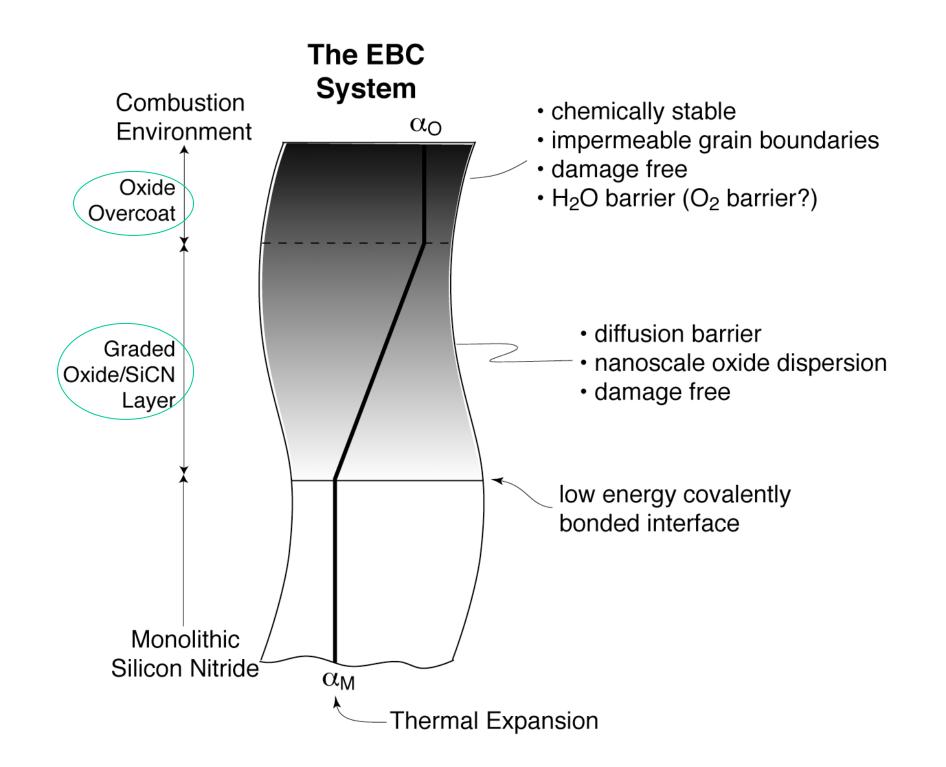
Opila et al. (JACerS)

The Design of a Graded Interface

Objective: prevent silicon nitride (SiO₂) volatilization

• oxide overlayer for chemical stability, isolation from humid environment

- graded interface prevents thermal shock, provides diffusion barrier for oxygen
- interfaces mechanically robust, nucleation barriers to silica formation



Elastic Energy Density is given by:

Monolithic Coating

$$U_{V}^{\circ} = f(\text{Elastic constants}) \cdot \Delta \alpha_{\circ}^{2} / \text{vol}$$

Graded Coating

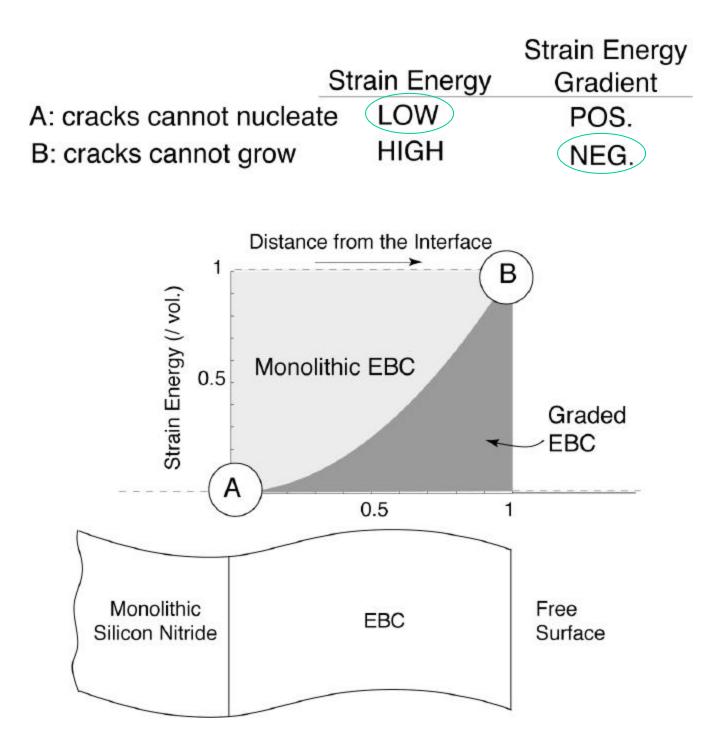
 $\Delta \alpha = \Delta \alpha_{o} \cdot \frac{z}{h}$

$$U_v(z) = f. (\Delta \alpha_o. \frac{z}{h})^2$$

graded interface for thermal shock resistance -ANALYSIS

	Energy Density /vol Total Energy /area		
Monolithic	f. $\Delta \alpha_0^2$	f. $\Delta \alpha_0^2$.h	
Graded	f. $(\Delta \alpha_{o} \cdot \frac{z}{h})^2$	$\frac{1}{3}$ f. $\Delta \alpha_0^2$.h	

h= total EBC thickness



Materials Selection (Oxide Overlayer)

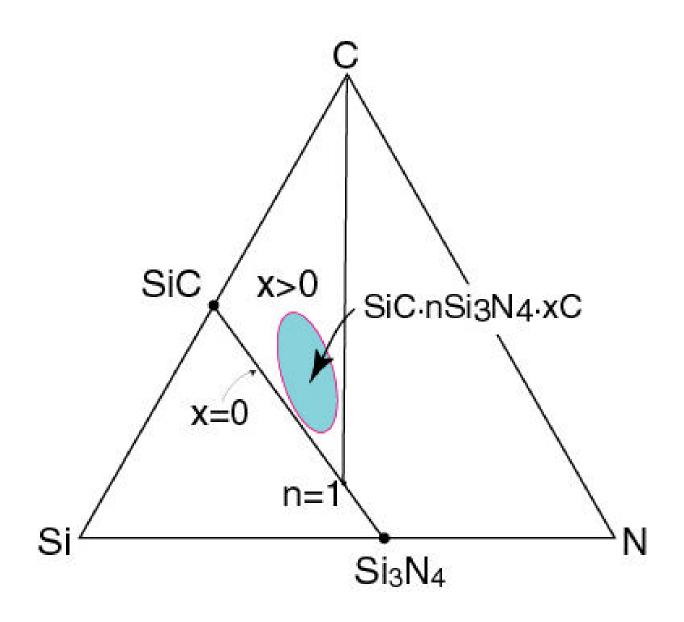
- Transition Metal Oxides (ZrO₂, HfO₂, Ta₂O₅, TiO₂)
- Base Metal Oxides (Al₂O₃, MgO etc.)
- Complex Oxides (YAG, Perovskites, etc.)
- Silicates (Mullite, etc.)

simple oxides are process friendly more likely to be implemented

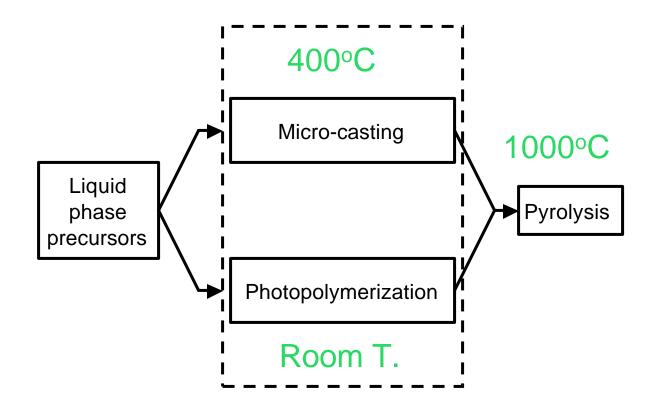
Why PDCs for the Gradient Layer?

- compatible with oxides
- liquid precursors: CVD, dip coating, for step-coverage
- low energy interfaces with oxides, Si₃N₄
- ultra-slow diffusion at ultrahigh temperatures





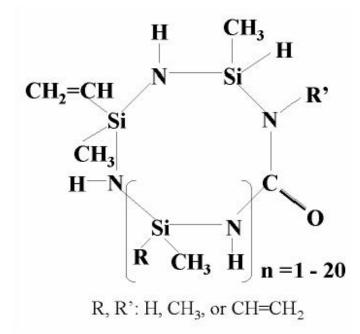
The PDC Process



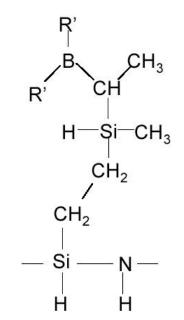


Organic Precursors for SiCN

<u>CERASET</u>

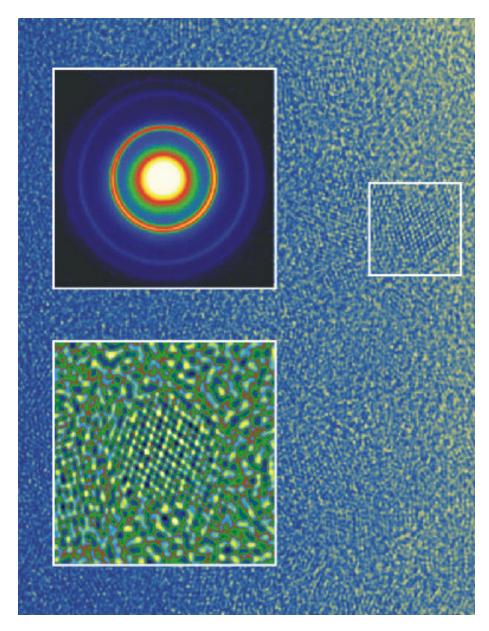




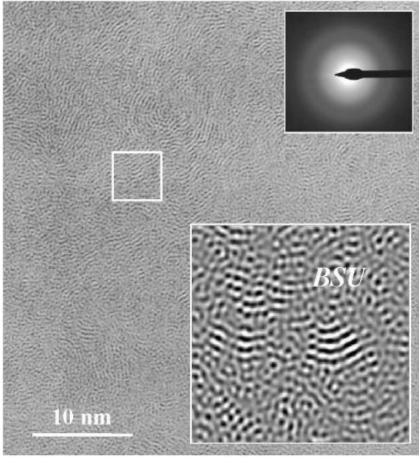


SiCN

SiCN Doped with B



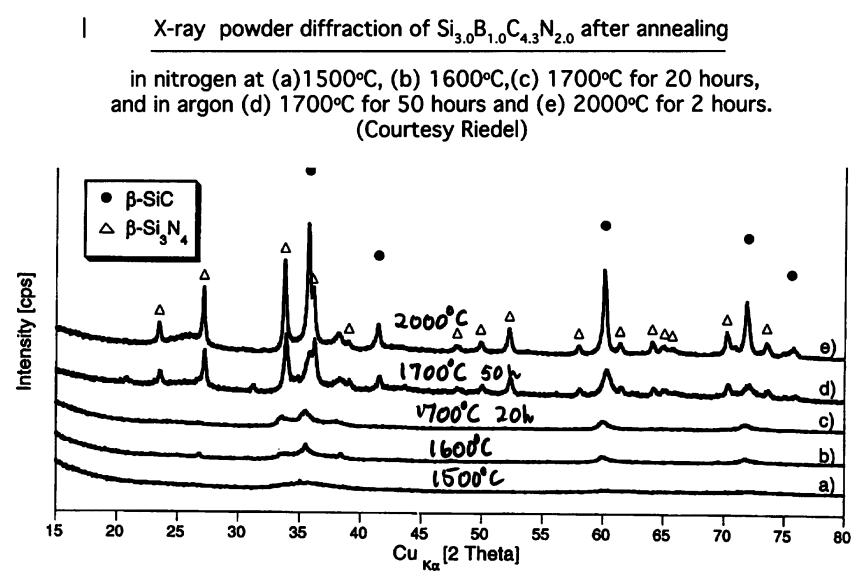
Special Issue JACerS, Oct. 20 01 Ultrahigh Temperatur e PDCs



H.-J. Kleebe (CSM)

Nanostructure Stable to UltraHigh Temperatures (Extremely Low Mobility)

The Amorphous State

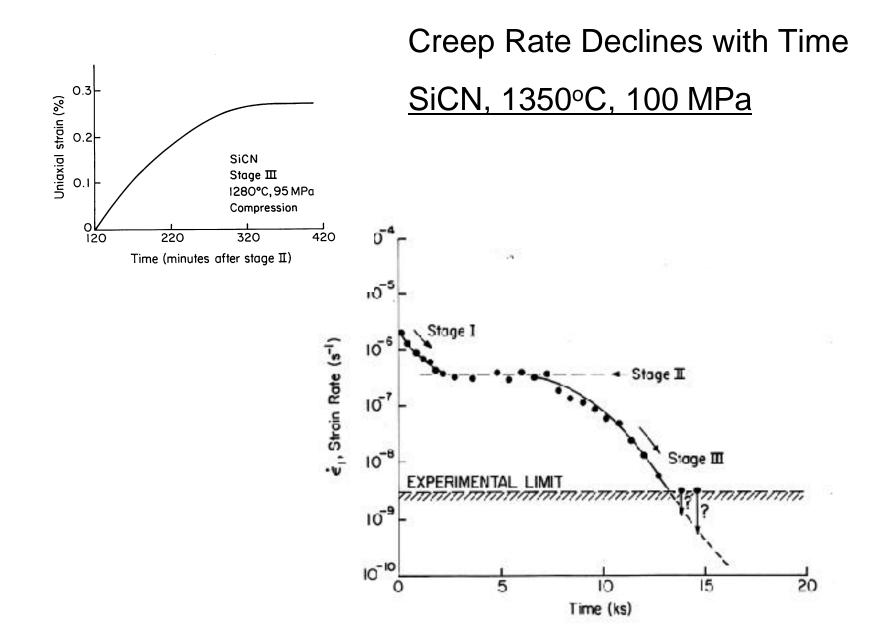


Properties of SiCN as compared to other materials

Property	SiCN	SiC	Si_3N_4
Density (g/cm ³)	2.35	3.17	3.19
E Modulus (GPa)	140-170	405	314
Poisson's Ratio	0.17	0.14	0.24
CTE (x10-6/K)	~ 3	3.8	2.5
Hardness (GPa)	25	30	28
Fracture Strength (MPa)	500-1200	418	700
Fracture Toughness (MPa.m1/2)	3.5	4 -6	5 - 8
Thermal Shock FOM*	1100-5000	270	890

*FOM=strength/(E-Modulus x CTE)

Creep Studies in Uniaxial Compression



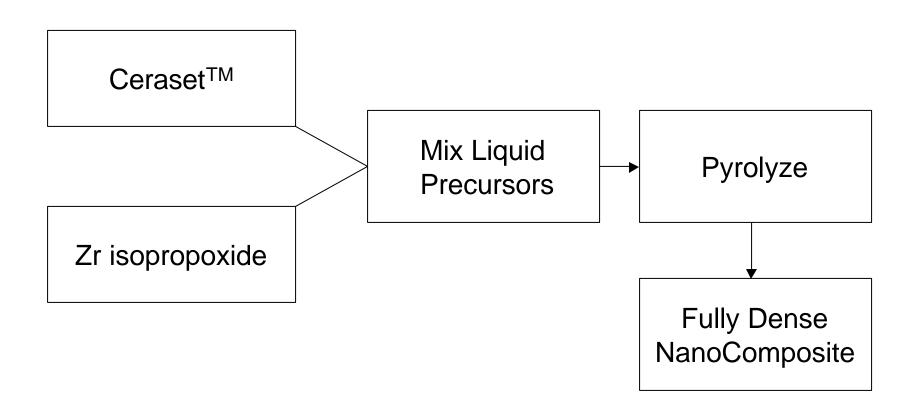
Summary of Creep Results

- mobile molecules are LARGE (~ 1-2 nm)
- long range diffusion extremely slow

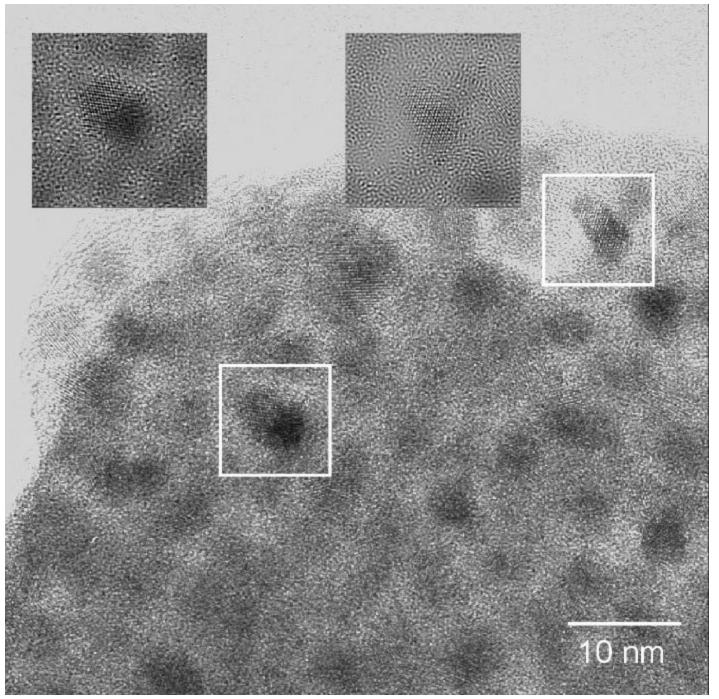
Concepts of Creep in (silicate) Glasses and in Polycrystalline Materials are NOT Applicable

SiCN - Zirconia NanoComposites

The Process

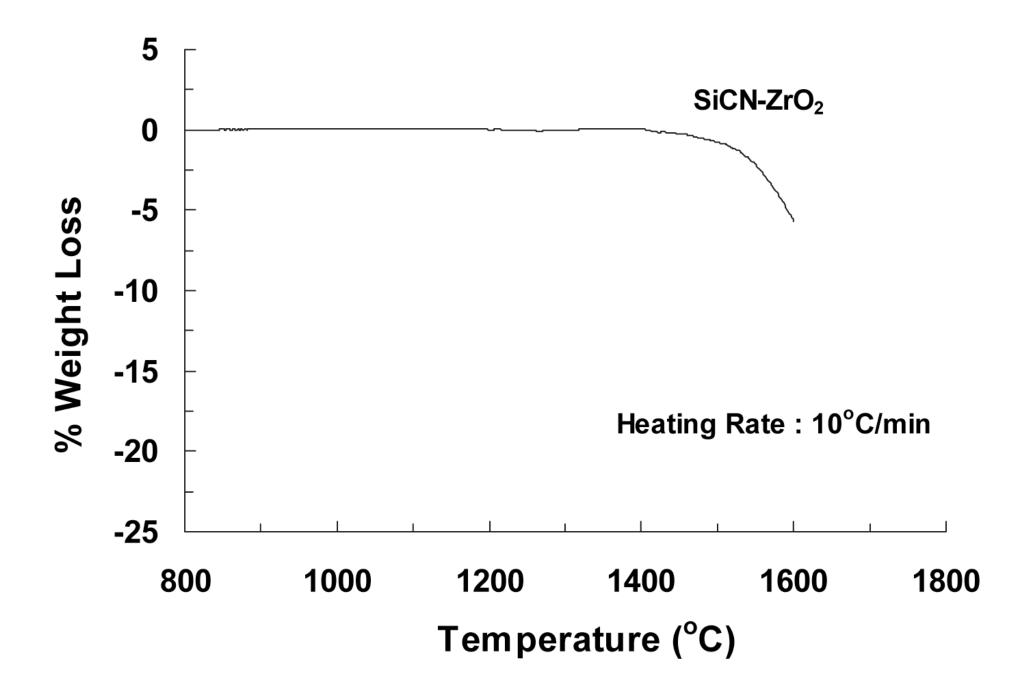


$SiZr_{0.13}C_{0.461}N_{0.785}O_{0.69}$



SiCN-Zirconia:

Courtesy Kleebe



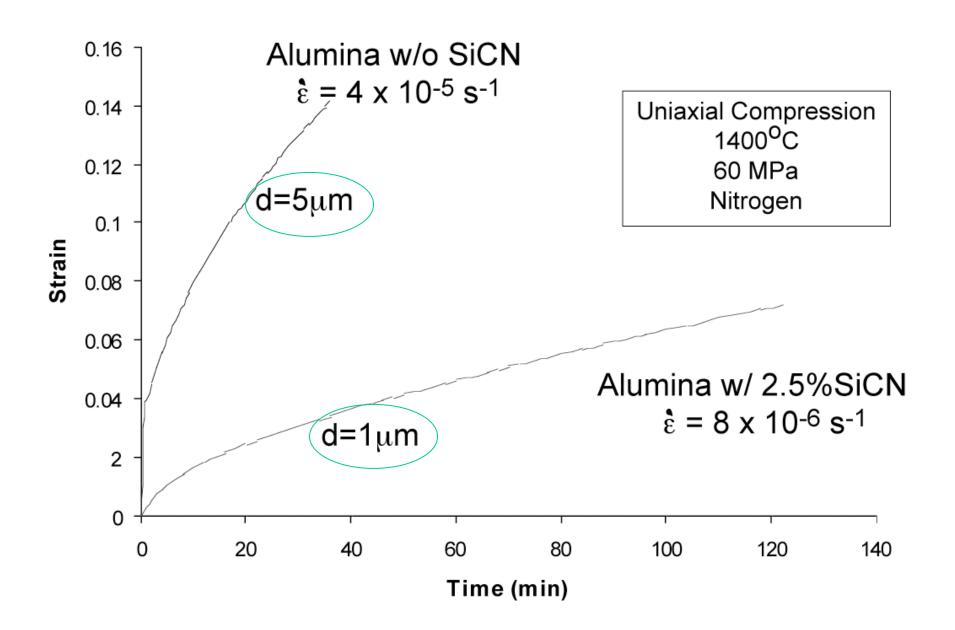
Summary of SiCN-ZrO₂ Results

- nanoscale oxide phase (will not thermal shock)
- high strength (2-3 GPa)
- thermally stable

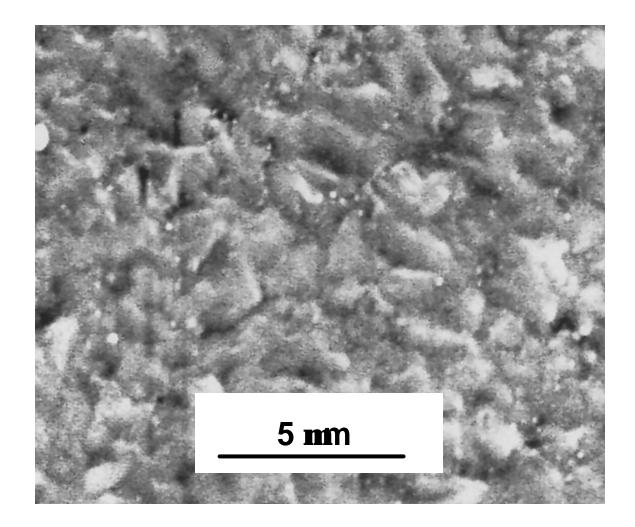
<u>Al₂O₃ - SiCN Composites</u>

- Al₂O₃ powder and SiCN liquid precursor-hot press
- compare grain growth w/ and w/o SiCN
- compare creep w/ and w/o SiCN

SiCN at Alumina-Grain Boundaries Reduces "d"-Normalized Creep Rate by 1/100 to 1/1000



Alumina w/ 2.5% SiCN



appearance unlike polycrystalline alumina

Preliminary Results from Al₂O₃ - SiCN Composites

- grain boundary kinetic phenomena (creep and grain growth) retarded by SiCN interfacial phase
- Al₂O₃ and SiCN form low-energy interfaces

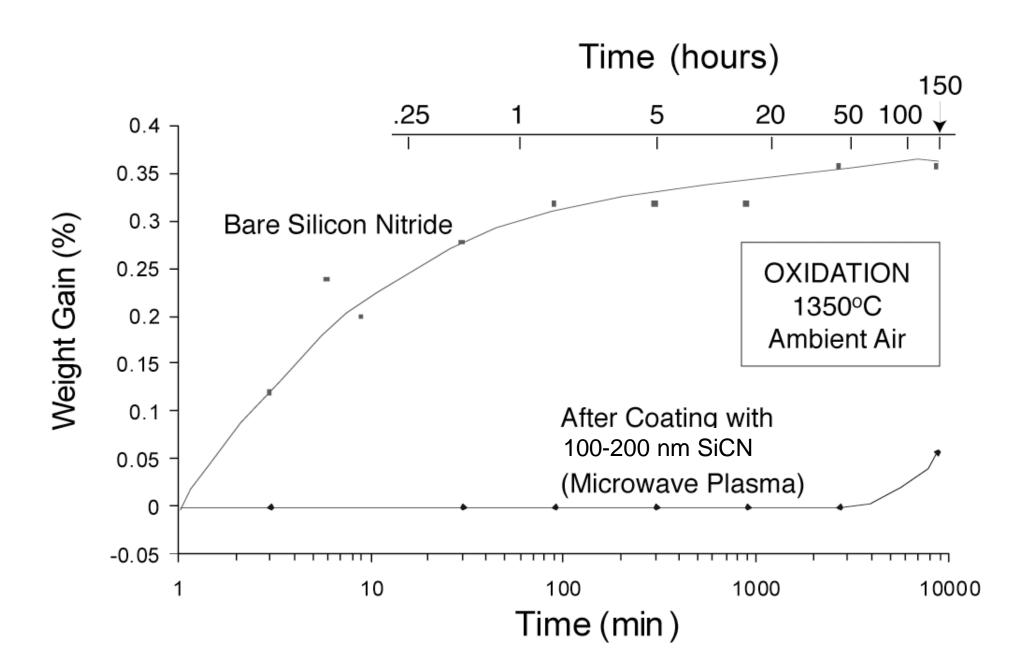
Oxides and SiCN good candidates for graded interfaces

The SiCN - Si_3N_4 Interface

<u>Thin Film SiCN on Si_3N_4 </u>

- processed by liquid injection/microwave plasma CVD
- 0.1-0.2 μ m thick film of SiCN on Si_3N_4
- compare oxidation of bare and coated Si₃N₄

Oxidation Protection from SiCN Thin-Films on Silicon-Nitride

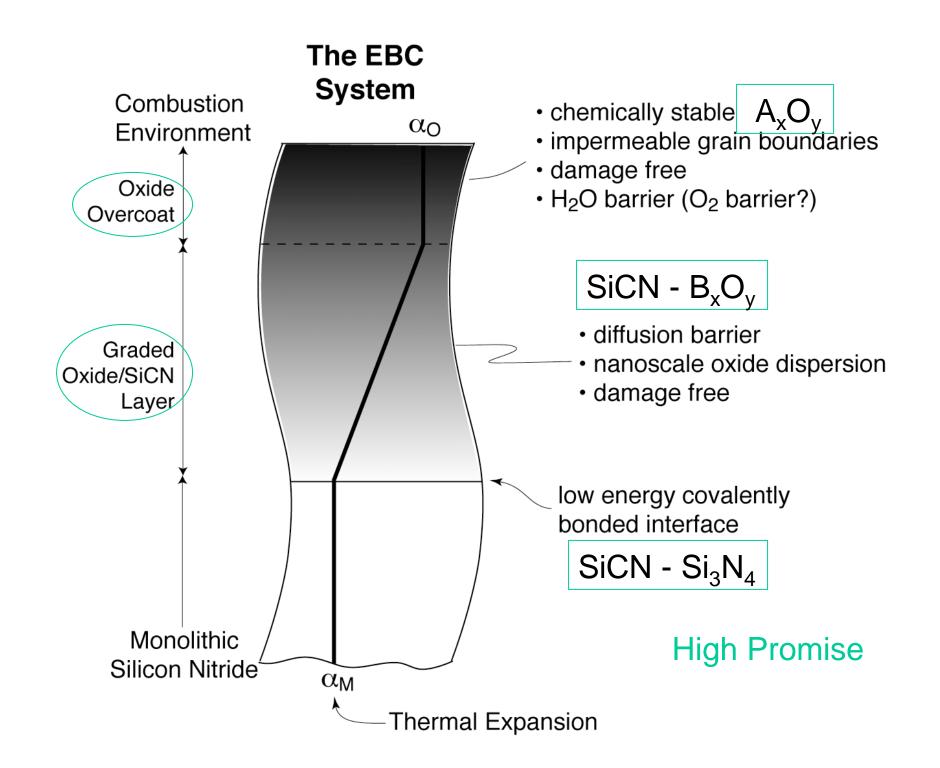


Summary of Results:

- good bonding of film to substrate (SiO₂ cannot nucleate at the SiCN/Si₃N₄ interface)

or

- SiCN effective as oxygen diffusion barrier



What are the basic research issues?

Objective: Suppress Volatilization (prevent silica growth)

- The surface oxide-overlayer damage free? -chemically stable? diffusion barrier?
- The oxide/SiCN *interface* prevents nucleation of silica?
- The graded PDC/oxide interlayer damage free? -immune to thermal shock? effective diffusion barrier? PDC & oxide phase equilibria?
- The SiCN/Si₃N₄ *interface* prevents nucleation of silica? not attacked by the sintering additives?
- <u>Processing</u> graded construction? step coverage? low cost?

the graded PDC coating process

